

**Search Notes**

Application/Control No.

10/509,102

Examiner

Andrew Lai

Applicant(s)/Patent under  
Reexamination

LE SAUZE ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
1: ((detect\$3 sens\$3 determin\$3 fnd\$3 decid\$3) near ((empty free unused) and (slot pacekt segment fragment frame cell)))	8/9/2007	AL
2: 1 & ((signal amplitude) near (level strangth))	8/12/2007	AL
3: 1 & (delay near (line circuit))	8/12/2007	AL
4: 1 & ((delay near (line circuit)) and (state near machine))	8/12/2007	AL
5: 1 & (optical SONEt ATM fiber fibre)	8/9/2007	AL
6: 5 & (dignal near level)	8/9/2007	AL